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Covalently interconnected transition metal dichalcogenide networks via defect engineering for high-performance electronic devices

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Solution-processed semiconducting transition metal dichalcogenides are at the centre of an ever-increasing research effort in printed (opto)electronics. However, device performance is limited by structural defects resulting from the exfoliation process and poor inter-flake electronic connectivity. Here, we report a new molecular strategy to boost the electrical performance of transition metal dichalcogenide-based devices via the use of dithiolated conjugated molecules, to simultaneously heal sulfur vacancies in solution-processed transition metal disulfides and covalently bridge adjacent flakes, thereby promoting percolation pathways for the charge transport. We achieve a reproducible increase by one order of magnitude in field-effect mobility (μ FE), current ratio ($1_{0,J/OFF}$) and switching time (1- $_5$) for liquid-gated transistors, reaching 10-² cm² V-¹ s-¹, 10⁴ and 18 ms, respectively. Our functionalization strategy is a universal route to simultaneously enhance the electronic connectivity in transition metal disulfide networks and tailor on demand their physicochemical properties according to the envisioned applications.

olution-processed layered materials have a wide-ranging portfolio of physicochemical properties, whose inherent features make them prime candidates for low-cost and scalable applications in (opto)electronics, (photo)catalysis, (bio)sensing and biomedicine¹-⁴ Much work has been done on the production and isolation of solution-processed semiconducting transition metal dichalcogenides (TMDs) by scalable methods⁵.⁷. Liquid-phase exfoliation (LPE) is the main route for preparing high-concentration and high-volume TMD dispersions^{8,9}, where bulk crystals are dispersed and exfoliated in a specific solvent via mechanical energy transfer that overcomes the van der Waals interactions within the layered structures. The high throughput achieved by LPE promotes the use of TMDs in many different applications, exploiting pristine or hybrid materials in the form of dispersions, coatings and thin-films produced by diverse deposition techniques, including inkjet printing, spray coating, roll-to-roll processing, dropcasting and so on•.7.10,11.

Although LPE provides the best trade-off amongst cost, purity and yield 11 , 12 , it has some limitations when the final application concerns (opto)electronics, where structural defects in the materials play a detrimental role 1 , 13 . One of the most widely employed LPE methods makes use of a tip horn sonicator that peels layered materials apart, thanks to vibrational and cavitation forces that arise from the generation and propagation of transverse waves within the solvent 14 . Consequently, the formation and implosion of cavitation bubbles generates energetic shock waves that induce localized temperature and pressure conditions that are sufficient to peel individual layers off the bulk structure, with a critical influence on their ultimate lateral size 15 . This energetic exfoliation procedure results in a mild formation of new defects and major propagation of inherent bulk defects in the exfoliated layers. As suggested by thermodynamic considerations, zero-dimensional defects are the most abundant stoichiometric deficiencies in TMDs, especially chalcogen vacancies mainly located at the flake edges and whose formation energy is a few eV (~2 eV in the case of sulfur vacancies)¹⁶.¹⁷. These structural defects strongly affect the electronic properties of solution-processed TMDs, with detrimental effects on the electrical performance ofrelated devices¹⁸.¹⁹.

Many groups have developed molecular strategies for tuning the physicochemical properties of solution-processed TMDs and overcoming the aforementioned limitations, enlarging their range of applicability in electronics and optoelectronics²"_22. In the case of electrical devices based on individual flakes, a promising strategy exploits thiolated molecular systems to heal sulfur vacancies in transition metal disulfides (MS₂), thereby restoring the pristine crystal structure of the material and enhancing its electrical properties²³.²⁴. Nevertheless, in thin-film TMD-based devices, an additional and limiting factor related to inter-flake electrical resistance emerges, resulting in a significant hindrance of charge-carrier transport²⁵.²⁶. This represents a major bottleneck in the development of solution-processed TMD-based optoelectronics, especially in large-area and high-performance device applications.

Here, we report a molecular strategy to simultaneously heal sulfur vacancies in solution-processed MS₂ (M=Mo, Wand Re) and increase the inter-flake electronic connectivity by means of dithiolated molecular systems. Using n-conjugated dithiolated molecules (HS-R-SH), we prove via diverse multiscale analysis the simultaneous: (1) healing of sulfur vacancies to restore the MS₂ crystal structure and decrease the related stoichiometric deficiencies acting as charge-scattering centres and (2) covalent bridging of adjacent

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Fig. 1 Functionalization strategy for production of covalently interconnected MS₂ networks. **a**, Schematic of ink deposition and in situ functionalization to produce MS₂ networks via BDT treatment. **b**, Schematic of sulfur-vacancy healing mechanism in MoS₂ films by means of dithiolated molecules and related inter-flake networking.

flakes, resulting in an enhanced charge-carrier transport through an interconnected network. We capitalize on the in situ functionalization approach of TMDs, exposing the inorganic materials to molecular linkers just after their deposition on a substrate. This is crucial for the formation oflong-range pathways that exhibit superior charge-transport characteristics, likewise the bridging of disordered regions in conjugated polymer chains²⁷.

Our approach is an innovative and universal functionalization method, capable of improving the performance of devices based on solution-processed MS₂ for large-area electronic applications. We apply this strategy in liquid-gated thin-film transistors (LG-TFTs) fabricated by dropcasting MS₂ dispersions on SiO/Si substrates pre-patterned with gold interdigitated electrodes (IDEs), followed by exposure to aromatic and conjugated 1,4-benzenedithiol (BDT) molecules. This boosts the characteristics of MS₂-based LG-TFTs by one order of magnitude, leading to state-of-the-art electrical performance in terms of field-effect mobilities (μ FE) and *IoNtoFF*> along with the fastest switching speed reported so far for devices of this kind²⁸. Improved water stability and mechanical robustness are other unique features exhibited by the covalently bridged MS₂ networks.

Device fabrication and in situ functionalization

 MS_2 colloidal dispersions (inks), where M=Mo, W and Re, are produced and characterized prior to their use in devices (see Supplementary Sections 1 and 2, Extended Data Fig. 1). MS_2 inks are then dropcast on SiO₂/Si substrates with 2.5-µm-spaced gold IDEs for TFT measurements. The ink deposition is performed on substrates placed onto a 110°C heated hotplate to assist solvent (2-propanol) evaporation and elimination of humidity traces during casting (Fig. la). Morphological characterizations (scanning electron microscopy and atomic force microscopy) of the deposited materials show a large-scale (micrometre) uniform coverage of the electrodes (important to enable charge-percolation pathways), a thickness of ~700 \pm 100nm and an average root-mean-squared roughness, R,.m.s. 95 \pm 10 nm over a 25 μ m² area (Supplementary Fig. 3a).

In our work, MS2 networks are formed by bridging adjacent flakes and taking advantage of the higher defect density at the edge sites with respect to basal planes, as confirmed by high-angle annular dark-field scanning transmission electron microscopy (HAADF-STEM) investigation (Supplementary Fig. 2, Extended Data Fig. 2). More specifically, the MS₂ thin-films are functionalized in a nitrogen-filled glovebox using a 50mM saturated solution ofBDT in anhydrous hexane to promote the formation of covalently linked MS₂ networks. The whole preparation of the BDT solution (weighing of powder and dissolution) is carried out under a nitrogen atmosphere to avoid thiol oxidation reactions induced by impurities²⁹. The coated slides are soaked in BDT solution at room temperature for 24 h inside a sealed container, followed by rinsing in hexane and annealing on a hotplate at 90 °C for 30 min. No remarkable morphological variations are detected after thiol exposure and the network features remain similar to those of pristine films (Supplementary Fig. 3b). The functionalization process is designed to simultaneously heal sulfur vacancies in MS₂ films and covalently bridge adjacent flakes, thereby promoting their modification at the molecular level (Fig. lb).



Fig. 21 Characterization of MS₂ films and networks. a, High-resolution S2p XPS spectra for MoS, film (top) and network (bottom). arb. units, arbitrary units. **b**, Raman spectra of MoS, film (black) and network (red), highlighting the two main E',. and A,. peaks related to in-plane and out-of-plane vibrations, respectively. **c**, Schematic of WCA results for MoS, film (left) and network (right). **d**, Schematics (top) and optical images (bottom) showing the different water stability of the MoS, film (left) and network (right).

Multiscale characterization of MS₂ networks

We assess the effects of in situ functionalization with BDT molecules by independent multiscale techniques. X-ray photoelectron spectroscopy (XPS) measurements provide evidence for MS2 chemical functionalization, as illustrated in Fig. 2a by the S2p high-resolution spectra of dropcast solution-processed MoS, before (as a film) and after (as a network) BDT treatment. The MoS, S2p spectrum displays two main peaks at ~162.3 and ~163.5eV, assigned to the $S2p_{312}$ and $S2p_{,12}$ components³⁰, respectively. An additional component can be deconvoluted at ~161.5 eV and ascribed to defects, for example, a vacancy neighbouring a sulfur atom^{30,31} Such a minority component at lower binding energies is due to the charge localized on sulfur that, once sulfur has been desorbed, can be redistributed on the first neighbouring atoms, enhancing Coulomb screening³⁰. The substoichiometric MoS,_x component at ~161.5 eV is related to unsaturated sulfur ligands³¹, such as sulfur vacancies, and decreases from 8.0 \pm 0.5% to 5.0 \pm 0.5% upon BDT treatment, proving how the exposure to thiolated molecules leads to a decrease of chalcogen vacancy defects in solution-processed MoS2. Since different sulfur ligands have minimal differences in binding energies, their identification in XPS spectra is not always straightforward and most

literature reports focus on just MoS, (see Supplementary Section 4 for further information on XPS data analysis, Extended Data Fig. 3). The Raman spectra of MoS, pristine films and networks (Fig. 2b) show no major differences, suggesting that the functionalization process does not damage the flakes. The full width at half maximum of both E_{26}^1 and A_{55} peaks narrows by ~10% upon thiol exposure, combined with a small blue shift and an increase of the E1,/A_{1g} intensity ratio (see Supplementary Section 5). This is consistent with a reduction in defect density and suppression of defect-activated modes^{12,33}. endorsing the healing of sulfur vacancies by thiolated molecules. A statistical Raman analysis of MoS, films and networks is provided in Supplementary Section 5.

Evidence of network formation comes from the distinctive characteristics and macroscopic properties of EDT-treated MS₂ samples. Pristine MoS₂ films on electrode-free SiO/Si substrates show hydrophilic behaviour, with an average static water contact angle (WCA), *a*, of $53 \pm 2^{\circ}$ in agreement with literature³⁴, whereas small fluctuations around these numbers depend on the material growth, exfoliation and deposition technique³⁵. Upon functionalization, the MoS, networks show strong hydrophobic behaviour characterized by an average *a* of $121 \pm 2^{\circ}$ (Fig. 2c), where the



Fig. 3 I Electrical properties of LG-TFTs based on MoS₂ films and networks, a, LG-TFT geometry. S, source; D, drain; G, gate; vd, source-drain voltage. **b**, Transfer curves for MoS₂ films and networks with vd, \equiv -100 mV and V. sweeping from -2.5 to +2.5 V. Inset shows the log-scale current characteristics and the equation for calculation *ofµ*". *9m*, transconductance; *L*, channel length; C, volumetric capacitance; W, channel width; *t*, film/network thickness. **c**, LG-TFT switching characteristics under V. step and corresponding time-dependent normalized current response (///₀). The red line delimits the range in which a non-linear fitting can be used to extrapolate ₁₅.

Table 11 Main figures of merit for electrical devices based of	n
MoS ₂ films and networks	

MoS₂film	MoS ₂ network
	10±1
,03	104
1.9±0.1	1.8±0.1
170±5	18±2
	MoS₂film ,03 1.9±0.1 170±5

Upon exposure to BDT and network formation, LG-TFTs exhibit a reproducible enhancement of one order of magnitude in the main device figures of merit, with minimal changes in Vrn,

free aromatic and non-polar ring of the BDT molecules remains exposed to the surface of the sample, increasing its hydrophobicity (see Supplementary Section 6). The network formation in BDT-functionalized MoS_2 samples improves the stability of the material in water (Fig. 2d and Supplementary Fig. 12). For MoS_2 pristine films we observe detachment and floating of the material exposed to water, whereas for MoS_2 networks the sample integrity is preserved. The salvation process is hindered within the MoS_2 network (less soluble than isolated free single flakes), consistent with the covalent interconnectivity promoted by dithiolated linkers. Such a feature is of primary importance for the fabrication of robust devices operating in an aqueous environment2. Additional evidence of network formation comes from the ex situ functionalization of MoS_2 flakes in solution^{36,37}, where the bridging process induced by the BDT linkers compromises the colloidal stability and undermines the electrical performance of the corresponding LG-TFTs (see Supplementary Section 9, Extended Data Fig. 4)^{38,39}. All the above-mentioned features of the networks cannot be achieved by using monothiolated functionalizing molecules (for example, thiophenol (TP)) that are unlikely to bridge adjacent flakes (see Supplementary Section 6, Extended Data Fig. 5). Improved mechanical robustness is observed in MS₂ networks deposited on flexible substrates and subjected to multiple (5,000-10,000) deformations, highlighting another advantageous effect of the covalent bridging (see Supplementary Section 6, Supplementary Fig. 13, Extended Data Fig. 6).

LG-TFTs based on MS₂ films and networks

The covalent bridging of individual MS_2 flakes with n-conjugated molecules is expected to improve the electrical properties, especially electrical connectivity, where long-range electronic delocalization is advocated²⁷. We thus investigate the performance of TFTs based on pristine MoS_2 films and networks. Dielectrically gated TFTs based on solution-processed TMDs show poor current switching ($I_{ONJOFF} < 10$)⁴u, encouraging one to focus on TFTs where the semiconductor layer is electrolytically gated by means of an ionic liquid solution (Fig. 3a), exploiting the inherent disorder and related porosity of the deposited materials. For LG-TFTs based on solution-processed TMD flakes, the liquid dielectric penetrates the internal free volume of the semiconducting material, thus gating the device volumetrically²⁸.

ARTICLES



Fig. 41 Temperature-dependent electrical characteristics. **a**, 300 K /-*E* curves with $Ve_{back=}0$ for MoS₂ film (black) and network (red). **b**, Schottky plot for MoS₂ film with $VG_{back=} 0$ V. Inset shows the band diagram for the Au/MoS₂ Schottky barrier interface. *Ee*, conduction band; *E*., Fermi level; w. valence band; IE, ionization energy; *X*, electron affinity. **c**, 300 K *1-E* characteristic with $V_{5ba^c} = +80$ V for MoS, film (black) and network (red). **d**, Arrhenius plot for MoS, network with $VG_{back=} +80$ V.

All our LG-TFT measurements are performed inside a glovebox under nitrogen atmosphere, to avoid side effects from environmental adsorbates, such as water and oxygen, that can induce strong p-doping4'. Figure 3b displays the transfer curves (Ids versus Vg, where Id, is the source-drain current and Vg is the sweeping gate voltage) of LG-TFTs based on MoS₂ films and networks. Both show n-type transfer characteristics, with the latter featuring an overall superior performance. In particular, MoS, networks exhibit higher μFE up to 10^{-2} cm²V⁻¹s⁻¹ and $I_ONIIOFF$ up to 10^4 . one order of magnitude greater than for pristine MoS, films (see Supplementary Section 7 for the calculation of the device figures of merit and related statistical analysis). No considerable differences in threshold voltage (V.m) are observed upon bridging of flakes, proving that BDT linkers mainly affect the conductivity of the networks in terms of μFE and not the charge-carrier density (doping effect)⁴².

Likewise, while applying a step-like Vg stimulus and measuring the device's time-dependent current response, a similar outcome is observed for the switching time (r_5) of LG-TFTs based on MoS₂ films and networks. Here, r_5 is ~170 ms for a MoS₂ film and ~18 ms for a network (Fig. 3c), meaning that covalently interconnected systems result in devices that are faster by one order of magnitude, with a state-of-the-art switching performance for transistors of this kind²⁸. The electrical characteristics and LG-TFT figures of merit of other solution-processed TMDs are shown in Supplementary Section 7. The reproducible tenfold enhancement of device performance observed for MS, networks supports the presence of covalent interconnections facilitated by n-conjugated and dithiolated linkers (Table 1), unachievable for monothiolated TP molecules that do not allow network formation (Supplementary Fig. 20). The bridging process of adjacent flakes obtained with aliphatic dithiolated molecules barely improves the electrical characteristics of MoS₂ LG-TFTs, whose performance cannot rival those achieved with BDT n-conjugated linkers (Supplementary Fig. 22, Extended Data Fig. 7).

Temperature-dependent electrical characteristics

MoS, films and networks are then analysed by measuring their current versus electric field (I-E) characteristics as a function of temperature (T) at high vacuum (10-⁶Torr). The samples are prepared on SiO/Si substrates with gold IDEs. The average E is calculated from V = Ex d, where V is the applied bias voltage and d is the IDE channel distance (2.5µm). The I-E relations are used with equations describing charge-transport models⁴³. The charge-transport characteristics are measured with and without a back-gate voltage (Veback) on the n++-Si substrate. At room temperature, and with Vcback=0, minor differences are found between the I-E traces of MoS₂ films and networks (Fig. 4a). For T ranging from 250 to 300 K, the current characteristics indicate Schottky emission as the dominant charge-transport mechanism (Fig. 4b). The formation of a Schottky barrier (Fig. 4b inset) with height of </>
B at the metal/ MoS₂ interface was previously investigated⁴⁴. From the thermionic emission formalism (Supplementary Equation (4))⁴³, we estimate Au/MoS, $\langle 1 \rangle B = 366 \pm 1 \text{ meV}$ for MoS, pristine films, $\langle 1 \rangle_0 = 285 \pm 7 \text{ meV}$

for MoS₂ networks and $<P_8 = 288 \pm 16$ meV for TP-functionalized MoS₂ (Supplementary Figs. 24 and 25). Such a reduction of <PB upon thiol functionalization (with both BDT and TP) points to either a modification of the Au work function (<PwF) and/or healing of the Au/MoS₂ interface states⁴⁵. Measurements of <PwF for Au electrode surfaces by photoelectron spectroscopy in air, before and after thiol treatment, reveal a small decrease from 5.11 \pm 0.02eV (bare Au) to 4.97 \pm 0.10eV and 4.93 \pm 0.0?eV for BDT and TP, respectively (Supplementary Table 6). Such a small <PwF change is consistent with the passivation of Au/MoS₂ interfaces states-due to the healing of sulfur vacancies in the material-as the main cause of $<P_8$ reduction in thiol-functionalized samples⁴⁵. Such a small <Pwr reduction, as well as similar values found for BDT- and TP-functionalized samples, cannot explain the enhanced device performance exhibited by MoS₂ networks in LG-TFTs.

As for LG-TFTs (Fig. 3), the superior electrical performance of MoS₂ networks arises when the Schottky barrier is attenuated by the application of a sweeping gate voltage, Vg (ref. ⁴⁶). Figure 4c plots the room-temperature I-E characteristics of samples under high $v_{G \text{ back}=}+80$ V. An approximate tenfold current difference is observed for MoS₂ networks when compared with films, especially at intermediate fields ($E = 10^5 - 10^6 Vm^{-1}$), a condition that mimics the LG-TFT operating parameters (E;:::; 10⁵ V m⁻¹). For T= 250-300K and E= 1 MV m-', MoS₂ films and networks have a thermally activated current response (Fig. 4d and Supplementary Fig. 26) with noticeably different activation energies (EA), \sim 512 \pm 12 and 360 \pm 10meV, respectively (Extended Data Fig. 8). Activation energies of hundreds of meV reflect the energy necessary to overcome the inter-flake barriers in MoS₂ systems²6, rather than low-energy (tens of meV) intra-flake conduction states²⁶. By sweeping $v_{G back}$ from -60 to +60 V, the temperature-dependent charge-carrier mobility $\mu(D)$ of films and networks follows an Arrhenius relation, with lower EA for networks (Supplementary Fig. 27). Hence, as inter-flake processes appear to be the limiting factor for charge transport within TMD thin films⁴1, a reduced EA points to a reduction in inter-flake junction resistance, which would be consistent with the observed mobility increase upon network formation. The activation energies for TP-functionalized samples (SOO \pm 1 meV) are only slightly smaller than the values found for pristine MoS2 films, revealing a reduction of trap states caused by the sulfur-vacancy healing mechanism, without any further improvement due to the inter-flake connectivity (see Supplementary Section 8).

Conclusions

We reported a universal and simple route for the production of covalently interconnected TMD networks by exploiting defect engineering in solution-processed layered materials. We used n-conjugated dithiolated molecules to bridge adjacent MS2 flakes, forming networks characterized by substantially different physicochemical properties (improved electrical characteristics, water stability and mechanical robustness). The bridging of neighbouring flakes at the molecular level improves the charge transport across the network, thereby leading to superior device performances. LG-TFTs show a reproducible increase by one order of magnitude in the main figures of merit, leading to a state-of-the-art field-effect mobility $(\sim 10^{-2} \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1})$ and I_{0N} IorF($\sim 10^4$), along with the fastest switching time (~18 ms) reported for devices of this kind^{28,47}. Our findings pave the way for the development of high-performance, large-area and printed electronics based on solution-processed TMDs. The network formation results in water-stable and mechanically robust MS₂-based devices that could be exploited in (bio)sensing⁴⁸, (photo) catalysis² and flexible optoelectronics⁴⁹. Ultimately, with an appropriate molecular design of the bridging linkers, one might endow the TMD networks with diverse functionalities, tuning the final properties on demand according to their final applications.

Online content

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ARTICLES

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